

**N-CHANNEL ENHANCEMENT MODE POWER MOSFET**

# MTNN18N03Q8

	N-CH 1	N-CH 2
$BV_{DSS}$	30V	60V
$I_D$	10A	0.115A
$R_{DSON(MAX)}$	18m $\Omega$	5 $\Omega$

## Description

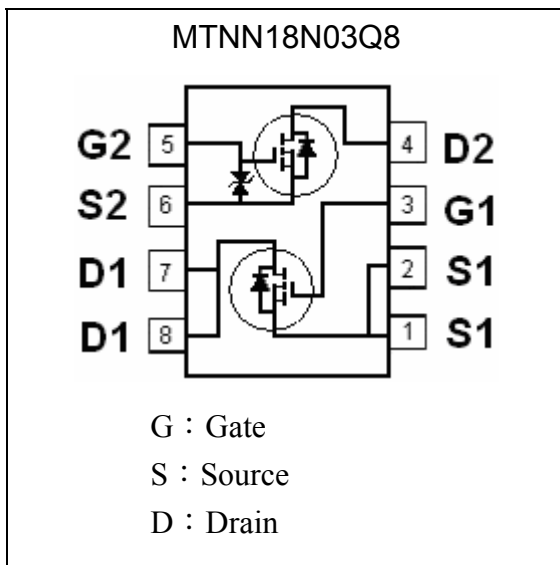
The MTNN18N03Q8 provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

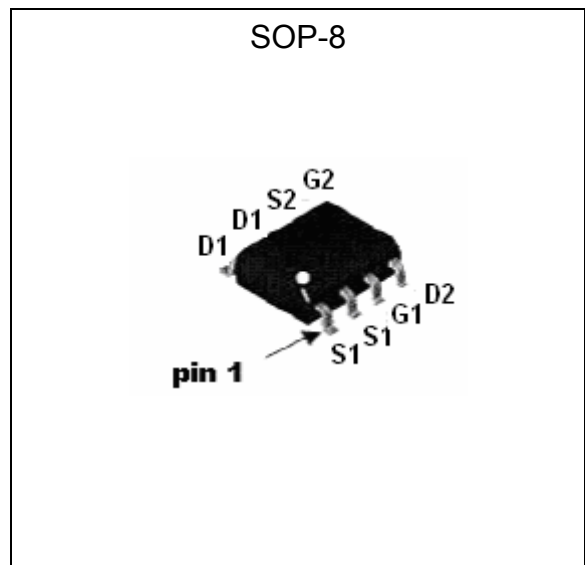
## Features

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Two N-ch MOSFETs in a package
- Pb-free lead plating package

## Equivalent Circuit



## Outline





**Absolute Maximum Ratings (Ta=25°C)**

Parameter	Symbol	Limits		Unit
		N-CH 1	N-CH 2	
Drain-Source Voltage	V <sub>DS</sub>	30	60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	±20	V
Continuous Drain Current @ T <sub>C</sub> =25 °C (Note 1)	I <sub>D</sub>	10	0.115	A
Continuous Drain Current @ T <sub>C</sub> =100 °C (Note 1)	I <sub>D</sub>	7	0.08	A
Pulsed Drain Current (Note 2&3)	I <sub>DM</sub>	40	0.7	A
Total Power Dissipation @ T <sub>A</sub> =25 °C Linear Derating Factor	P <sub>d</sub>	2	0.4	W
		0.016	0.016	W / °C
ESD susceptibility (Note 4)			1250	V
Operating Junction Temperature	T <sub>j</sub>	-55~+150		°C
Storage Temperature	T <sub>stg</sub>	-55~+150		°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R <sub>th,ja</sub>	62.5		°C/W

- Note : 1. Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board; 135°C/W when mounted on minimum copper pad.  
 2. Pulse width limited by maximum junction temperature.  
 3. Pulse width ≤ 300µs, duty cycle ≤ 2%.  
 4. Human body model, 1.5kΩ in series with 100pF.

**Characteristics (Tj=25°C, unless otherwise specified)**

**N-Channel MOSFET 1**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250µA
V <sub>GS(th)</sub>	1.0	-	3.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250µA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20
I <sub>DSS</sub>	-	-	1	µA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0
	-	-	25		V <sub>DS</sub> =24V, V <sub>GS</sub> =0, T <sub>j</sub> =125°C
*R <sub>DS(ON)</sub>	-	12	18	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =10A
	-	17	20		V <sub>GS</sub> =4.5V, I <sub>D</sub> =8A
<b>Dynamic</b>					
*Q <sub>g</sub> (V <sub>GS</sub> =10V)	-	19	-	nC	I <sub>D</sub> =10A, V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V
*Q <sub>g</sub> (V <sub>GS</sub> =4.5V)	-	9.4	-		
*Q <sub>gs</sub>	-	4.2	-		
*Q <sub>gd</sub>	-	3.8	-		
*t <sub>d(ON)</sub>	-	15	-	ns	V <sub>DS</sub> =25V, I <sub>D</sub> =1A, V <sub>GS</sub> =10V, R <sub>G</sub> =6Ω, R <sub>L</sub> =25Ω
*t <sub>r</sub>	-	10	-		
*t <sub>d(OFF)</sub>	-	43	-		
*t <sub>f</sub>	-	7	-		
C <sub>iss</sub>	-	731	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz
C <sub>oss</sub>	-	116	-		
C <sub>rss</sub>	-	36	-		
R <sub>g</sub>	-	1	-	Ω	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz



Source-Drain Diode					
*I <sub>S</sub>	-	-	2.3	A	I <sub>S</sub> =2.3A, V <sub>GS</sub> =0V I <sub>F</sub> =I <sub>S</sub> , V <sub>GS</sub> =0, dI/dt=100A/μs
*I <sub>SM</sub>	-	-	9.2		
*V <sub>SD</sub>	-	0.7	1.1	V	
*t <sub>rr</sub>	-	50	-	ns	
*Q <sub>rr</sub>	-	2	-	nC	

**N-Channel MOSFET 2**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
BV <sub>DSS</sub> *	60	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =10μA
V <sub>GS(th)</sub>	1	-	2.5	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>GSS</sub>	-	-	±10	μA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =60V, V <sub>GS</sub> =0
R <sub>DS(ON)</sub> *	-	3.6	5.5	Ω	I <sub>D</sub> =100mA, V <sub>GS</sub> =5V
	-	3	5		I <sub>D</sub> =100mA, V <sub>GS</sub> =10V
G <sub>FS</sub>	100	-	-	mS	V <sub>DS</sub> =10V, I <sub>D</sub> =100mA
C <sub>iss</sub>	-	30.5	-	pF	V <sub>DS</sub> =10V, V <sub>GS</sub> =0, f=1MHz
C <sub>oss</sub>	-	9.3	-		
C <sub>rss</sub>	-	5.9	-		

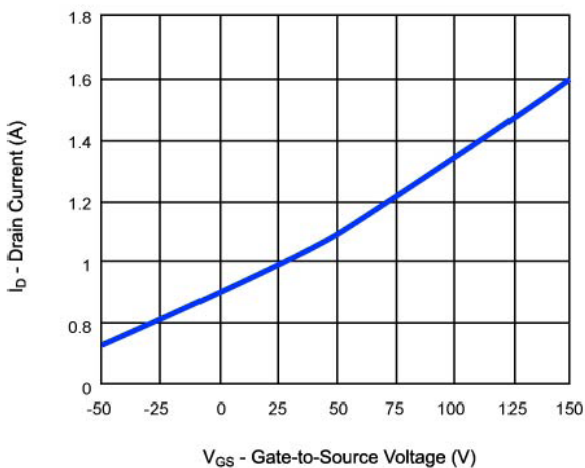
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

**Ordering Information**

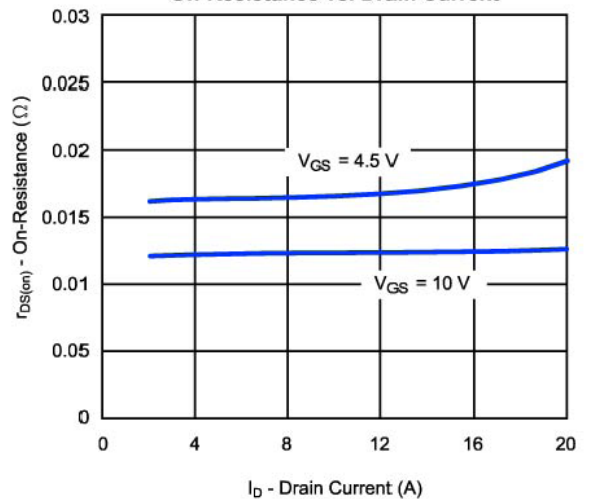
Device	Package	Shipping
MTNN18N03Q8	SOP-8 (Pb-free lead plating package)	3000 pcs / Tape & Reel

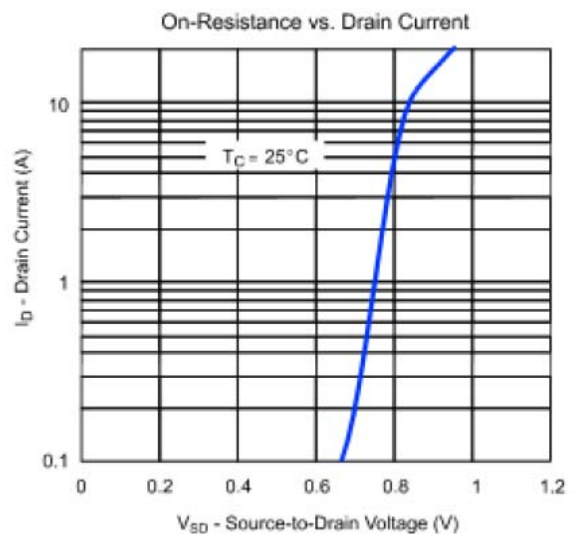
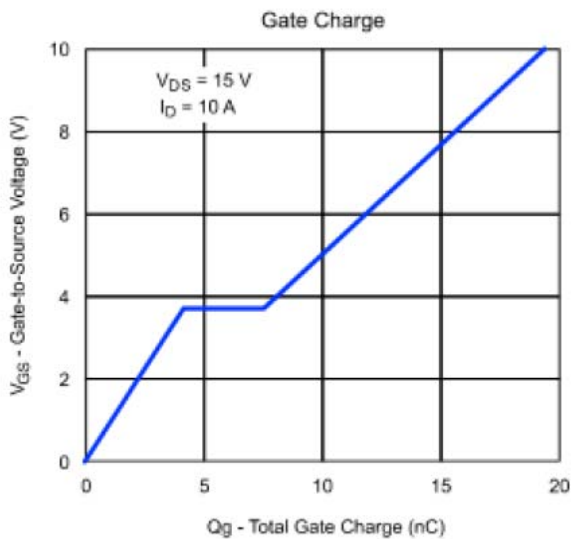
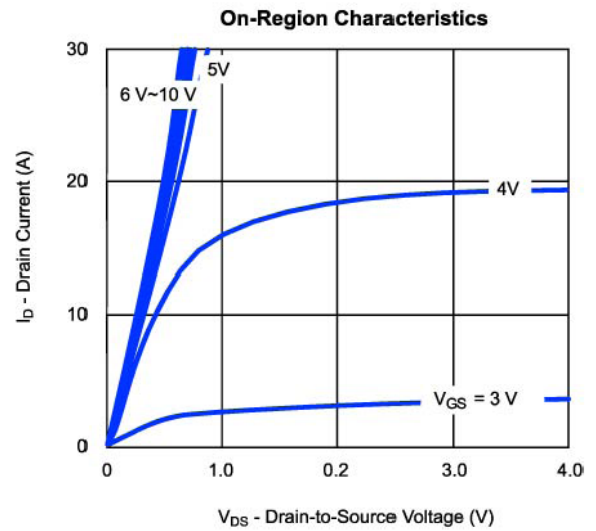
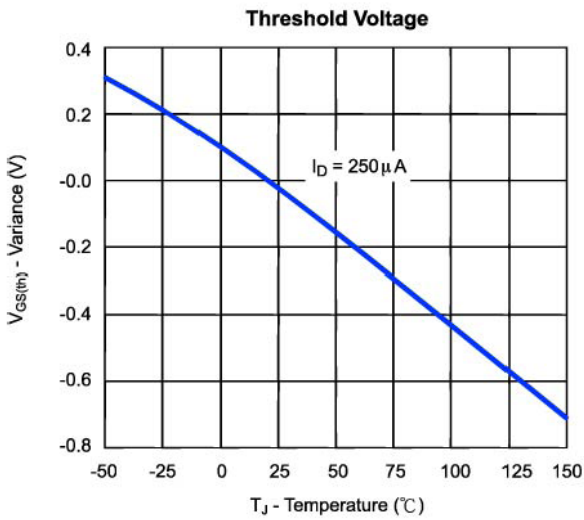
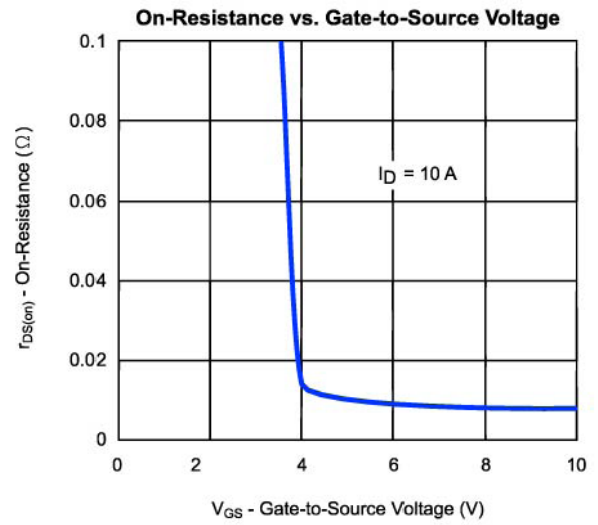
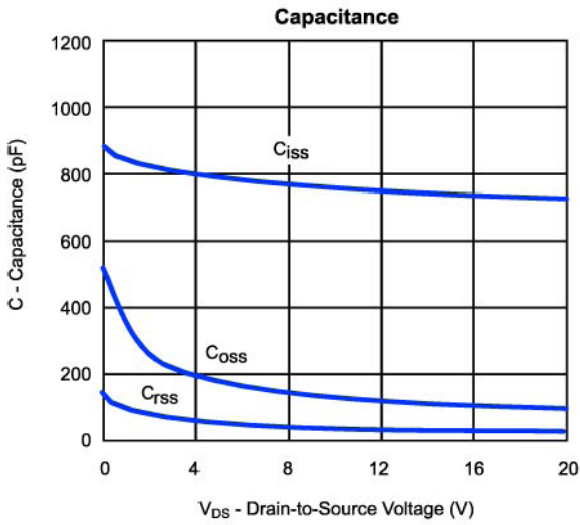
**Typical Characteristics  
N-CH MOSFET 1**

Transfer Characteristics



On-Resistance vs. Drain Current

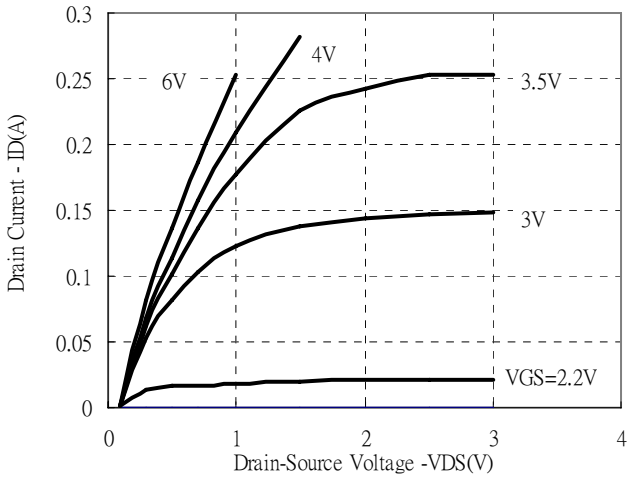




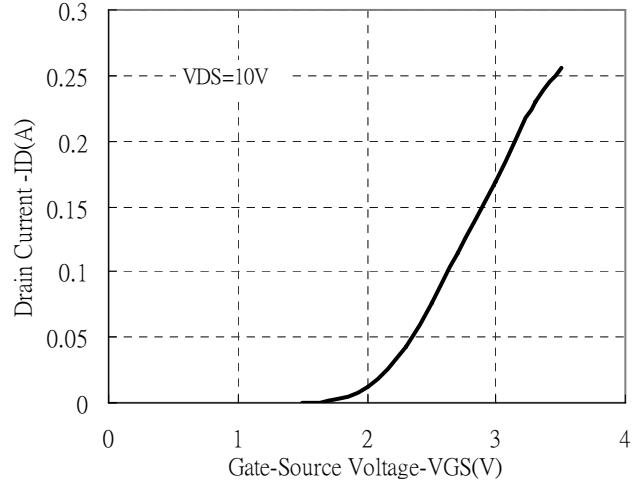


### N-CH MOSFET 2

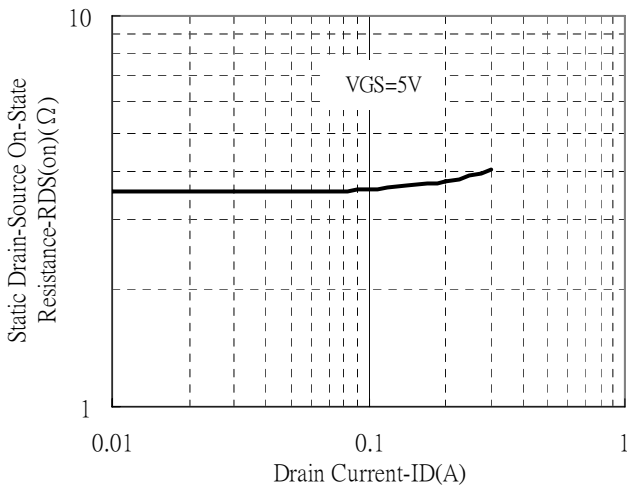
Typical Output Characteristics



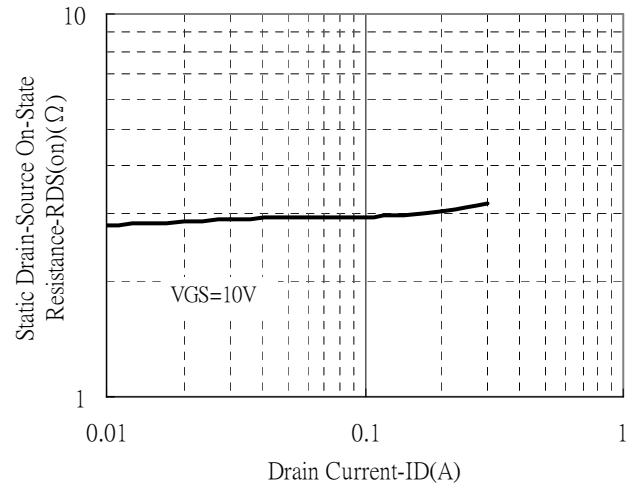
Typical Transfer Characteristics



Static Drain-Source On-State resistance vs Drain Current

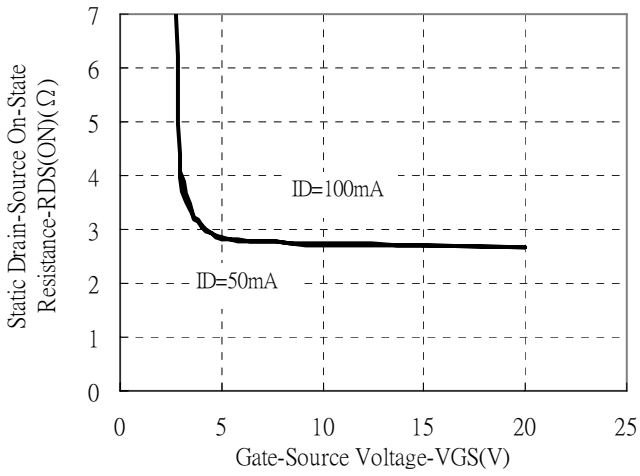


Static Drain-Source On-State resistance vs Drain Current

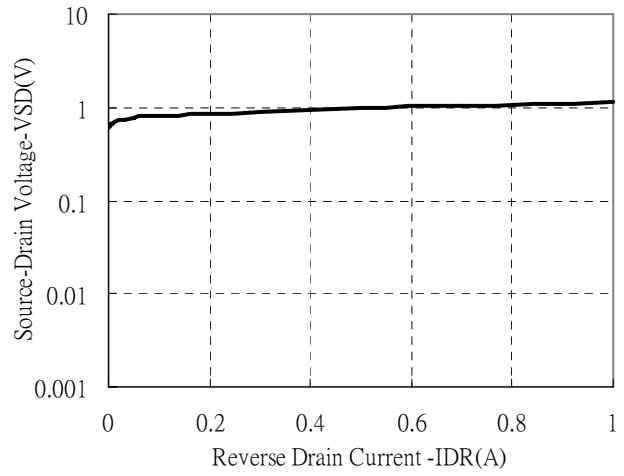




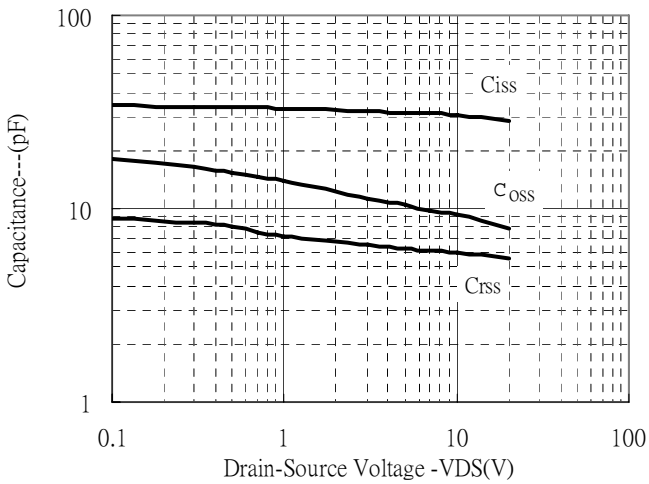
Static Drain-Source On-State Resistance vs Gate-Source Voltage



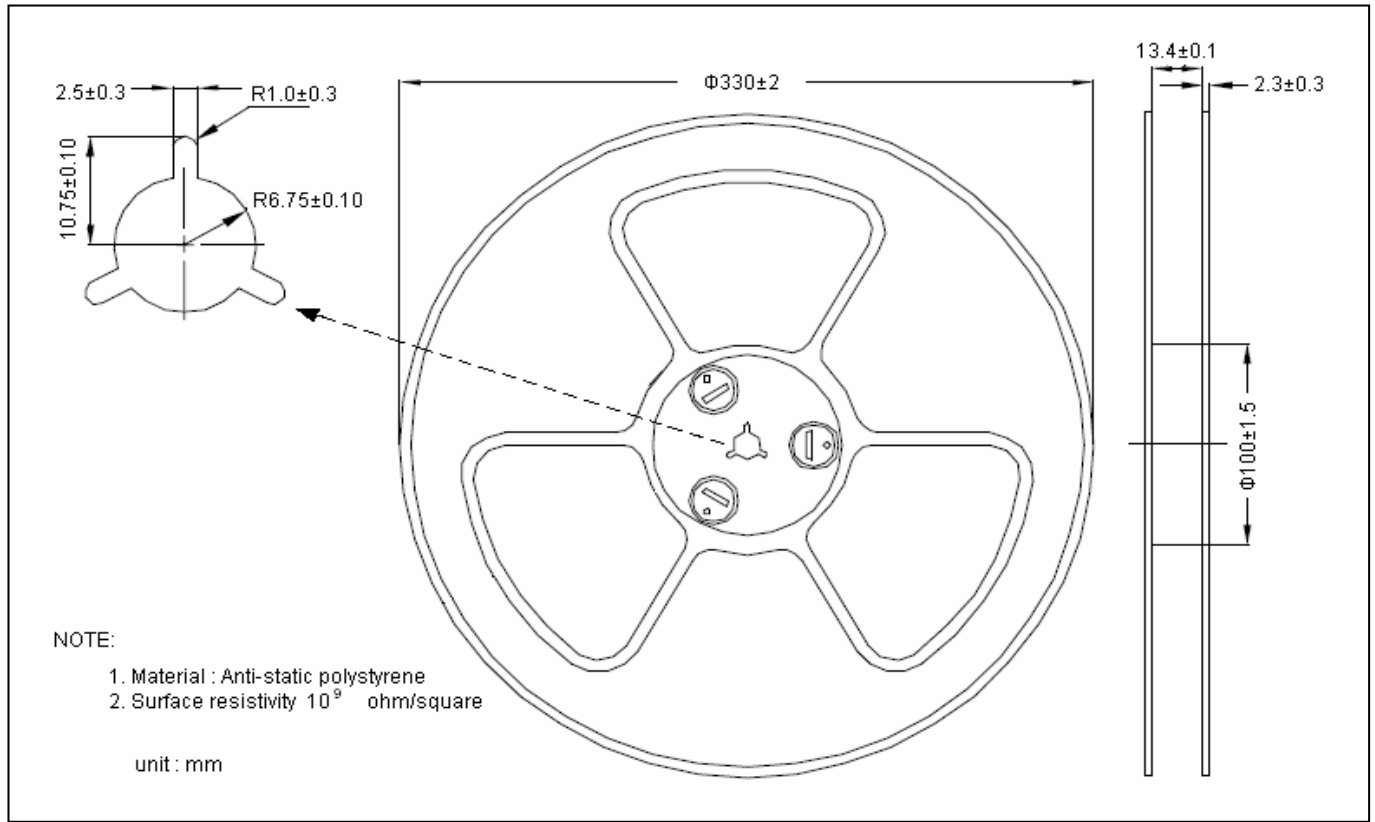
Reverse Drain Current vs Source-Drain Voltage



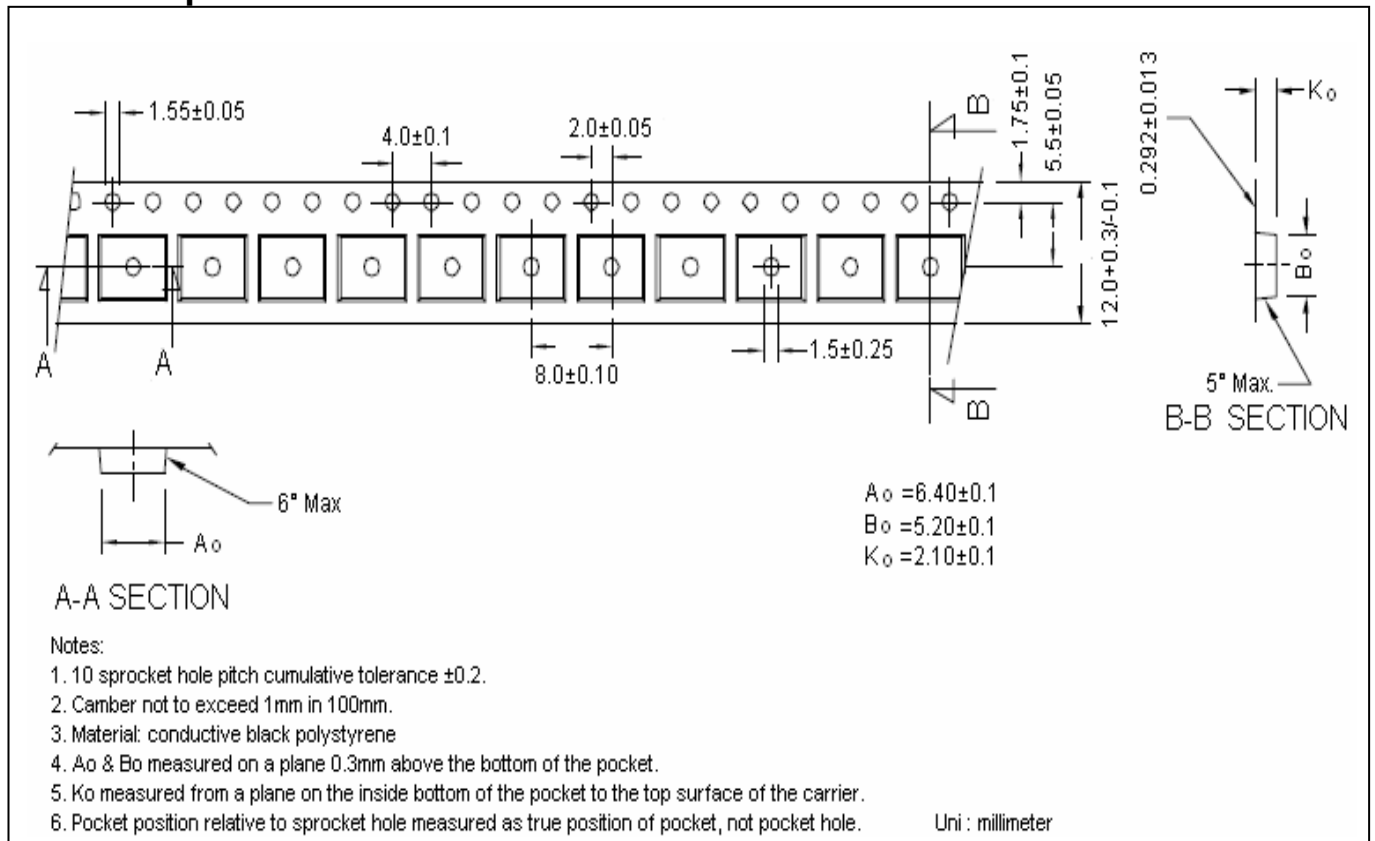
Capacitance vs Drain-to-Source Voltage



**Reel Dimension**



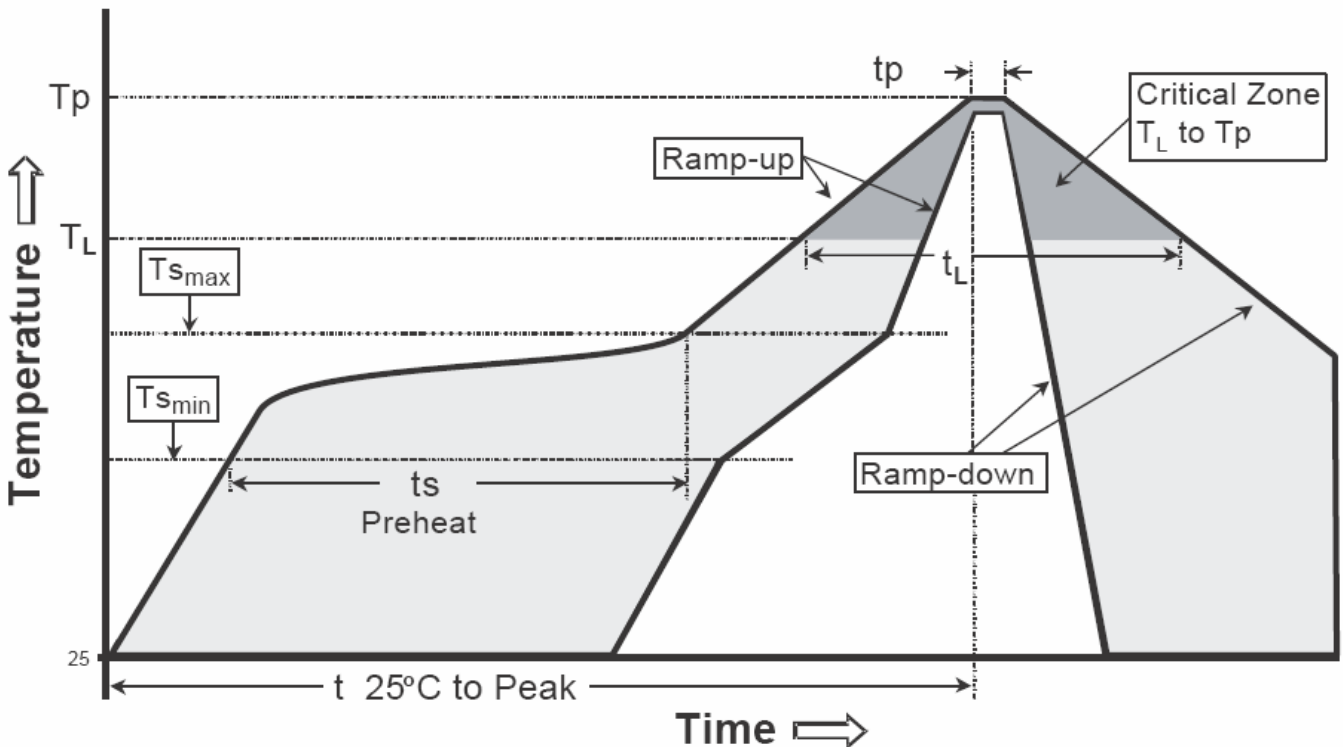
**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**

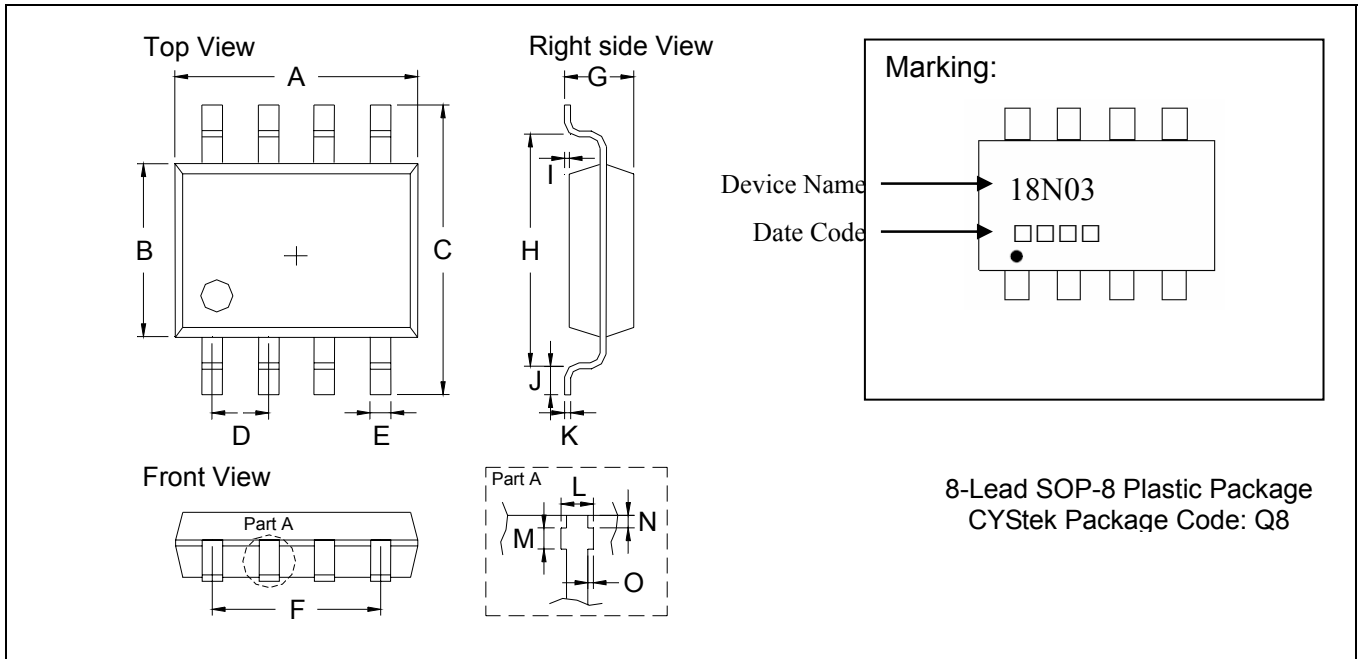


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.



**SOP-8 Dimension**



\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1890	0.2007	4.80	5.10	I	0.0098	REF	0.25	REF
B	0.1496	0.1654	3.80	4.20	J	0.0118	0.0354	0.30	0.90
C	0.2283	0.2441	5.80	6.20	K	0.0074	0.0098	0.19	0.25
D	0.0480	0.0519	1.22	1.32	L	0.0145	0.0204	0.37	0.52
E	0.0138	0.0193	0.35	0.49	M	0.0118	0.0197	0.30	0.50
F	0.1472	0.1527	3.74	3.88	N	0.0031	0.0051	0.08	0.13
G	0.0531	0.0689	1.35	1.75	O	0.0000	0.0059	0.00	0.15
H	0.1889	0.2007	4.80	5.10					

- Notes: 1. Controlling dimension: millimeters.  
 2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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